

Search Notes

Application/Control No.

10/722,186

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

KAMASAKI ET AL.

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	773	4/15/2007	LEE
715	810,817	11/12/2007	LEE
	818, 840		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	as above	4/15/2007	LEE

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search attached	4/15/2007	LEE
East search attached	11/12/2007	LEE
NPL search, ACM digital library	11/13/2007	LEE